

## Notice of References Cited

Application/Control No.

09/291,798

Examiner

David Odland

Applicant(s)/Patent Under Reexamination SOLUM, JEFF

Art Unit
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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,392,287	02-1995	Tiedemann et al.	340/7.34
	В	US-5,764,734	06-1998	Medendorp et al.	379/90.01
	С	US-6,178,447	01-2001	Wannenmacher et al.	375/222
	D	US-6,208,266	03-2001	Lyons et al.	340/870.01
	Е	US-5,544,082	08-1996	Garcia-Duarte et al.	702/186
	F	US-5,491,721	02-1996	Cornelius et al.	375/222
	G	US-6,304,596	10-2001	Yamano et al.	370/389
	Н	US-6,307,881	10-2001	Noma et al.	358/434
	ı	US-6,233,235	05-2001	Burke et al.	370/356
	J	US-6,075,787	06-2000	Bobeck et al.	370/395.2
	К	US-5,881,361	03-1999	Mannette et al.	725/148
	L	US-6,131,023	10-2000	Matsuura, Syuuji	348/731
	М	US-6,160,572	12-2000	Matsuura, Syuuji	348/731

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т			, <b>r</b>		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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